


<b>Search Notes</b> 	<b>Application/Control No.</b> 10552056	<b>Applicant(s)/Patent Under Reexamination</b> DE HAAN, GERARD
	<b>Examiner</b> M. Lee	<b>Art Unit</b> 2622

SEARCHED			
Class	Subclass	Date	Examiner
348	441-459, 558,	3/1/09	ml
382	261, 266	3/1/09	ml

SEARCH NOTES		
Search Notes	Date	Examiner
east	3/1/09	ml

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/M. Lee/ Primary Examiner.Art Unit 2622
--	--